

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>				Docket Number (Optional) LVIP:114US		Application Number 10/711,406	
				Applicant(s) Reinhard Lihl et al.		EXAMINER Zahra I. Bennett	
				Filing Date 09/16/2004		Group Art Unit 2875	

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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ZB		2004/0035275 A1	02/26/2004	Lihl et al.	83	520	06/27/2003

FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO

OTHER DOCUMENTS			(Including Author, Title, Date, Pertinent Pages, Etc.)
		Leica Mikrosysteme AG, Vienna, Walter Bilek, Leica EM FCS - Low Temperature Sectioning System according to Sitte, pages 1-3, April, 1999, Vienna, Austria	

EXAMINER 	DATE CONSIDERED 1/30/06
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.